



Integrated Device Technology, Inc.

256K x 32 BiCMOS/CMOS STATIC RAM MODULE

IDT7MP4045

FEATURES:

- High density 1 megabyte static RAM module
- Low profile 64 pin ZIP (Zig-zag In-line vertical Package) or 64 pin SIMM (Single In-line Memory Module)
- Ultra fast access time: 10ns (max.)
- Surface mounted plastic components on an epoxy laminate (FR-4) substrate
- Single 5V ($\pm 10\%$) power supply
- Multiple GND pins and decoupling capacitors for maximum noise immunity
- Inputs/outputs directly TTL-compatible

PIN CONFIGURATION⁽¹⁾

PD0	2	1	GND	PD0 - GND
I/O0	4	3	PD1	PD1 - GND
I/O1	6	5	I/O8	
I/O2	8	7	I/O9	
I/O3	10	9	I/O10	
Vcc	12	11	I/O11	
A7	14	13	A0	
A8	16	15	A1	
A9	18	17	A2	
I/O4	20	19	I/O12	
I/O5	22	21	I/O13	
I/O6	24	23	I/O14	
I/O7	26	25	I/O15	
WE	28	27	GND	
A14	30	29	A15	
CS1	32	31	CS2	
CS3	34	33	CS4	
A16	36	35	A17	
GND	38	37	OE	
I/O16	40	39	I/O24	
I/O17	42	41	I/O25	
I/O18	44	43	I/O26	
I/O19	46	45	I/O27	
A10	48	47	A3	
A11	50	49	A4	
A12	52	51	A5	
A13	54	53	Vcc	
I/O20	56	55	A6	
I/O21	58	57	I/O28	
I/O22	60	59	I/O29	
I/O23	62	61	I/O30	
GND	64	63	I/O31	

ZIP, SIMM
TOP VIEW

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NOTE:

1. Pins 2 and 3 (PD0 and PD1) are read by the user to determine the density of the module. If PD0 reads GND and PD1 reads GND, then the module had a 256K depth.

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COMMERCIAL TEMPERATURE RANGE

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DESCRIPTION:

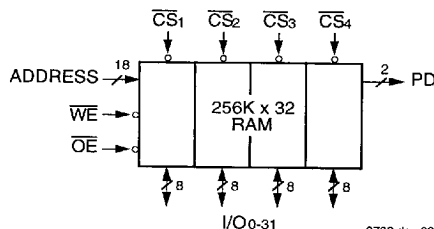
The IDT7MP4045 is a 256K x 32 static RAM module constructed on an epoxy laminate (FR-4) substrate using 8 256K x 4 static RAMs in plastic SOJ packages. Availability of four chip select lines (one for each group of two RAMs) provides byte access. The IDT7MP4045 is available with access time as fast as 10ns with minimal power consumption.

The IDT7MP4045 is packaged in a 64 pin FR-4 ZIP (Zig-zag In-line vertical Package) or a 64 pin SIMM (Single In-line Memory Module). The ZIP configuration allows 64 pins to be placed on a package 3.65 inches long and 0.365 inches wide. At only 0.585 inches high, this low profile package is ideal for systems with minimum board spacing while the SIMM configuration allows use of edge mounted sockets to secure the module.

All inputs and outputs of the IDT7MP4045 are TTL-compatible and operate from a single 5V supply. Full asynchronous circuitry requires no clocks or refresh for operation and provides equal access and cycle times for ease of use.

Two identification pins (PD0 and PD1) are provided for applications in which different density versions of the module are used. In this way, the target system can read the respective levels of PD0 and PD1 to determine a 256K depth.

FUNCTIONAL BLOCK DIAGRAM



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PIN NAMES

I/O0-31	Data Inputs/Outputs
A0-17	Addresses
CS1-4	Chip Selects
WE	Write Enable
OE	Output Enable
PD0-1	Depth Identification
Vcc	Power
GND	Ground

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CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Max.	Unit
C _{IN(C)}	Input Capacitance (CS)	V _(IN) = 0V	20	pF
C _{IN(A)}	Input Capacitance (Address & Control)	V _(IN) = 0V	70	pF
C _{I/O}	I/O Capacitance	V _(OUT) = 0V	12	pF

NOTE:

1. This parameter is guaranteed by design but not tested.

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RECOMMENDED DC OPERATING CONDITIONS

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{CC}	Supply Voltage	4.5	5.0	5.5	V
GND	Supply Voltage	0	0	0	V
V _{IH}	Input High Voltage	2.2	—	6.0	V
V _{IL}	Input Low Voltage	-0.5 ⁽¹⁾	—	0.8	V

NOTE:

1. V_{IL} (min) = -1.5V for pulse width less than 10ns.

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RECOMMENDED OPERATING TEMPERATURE AND SUPPLY VOLTAGE

Grade	Ambient Temperature	GND	V _{CC}
Commercial	0°C to +70°C	0V	5.0V ± 10%

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DC ELECTRICAL CHARACTERISTICS

(V_{CC} = 5.0V ± 10%, TA = 0°C to +70°C)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
I _{LI}	Input Leakage (Address and Control)	V _{CC} = Max.; V _{IN} = GND to V _{CC}	—	80	μA
I _{LI}	Input Leakage (Data)	V _{CC} = Max.; V _{IN} = GND to V _{CC}	—	10	μA
I _{LO}	Output Leakage	V _{CC} = Max.; CS = V _{IH} , V _{OUT} = GND to V _{CC}	—	10	μA
V _{OL}	Output LOW	V _{CC} = Min., I _{OL} = 8mA	—	0.4	V
V _{OH}	Output HIGH	V _{CC} = Min., I _{OH} = -4mA	2.4	—	V

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Symbol	Parameter	Test Conditions	10ns, 12ns Max.	15ns - 25ns Max.	Unit
I _{CC}	Dynamic Operating Current	f = f _{MAX} ; CS = V _{IL} V _{CC} = Max.; Output Open	1600	1360	mA
I _{SB}	Standby Supply Current	CS ≥ V _{IH} , V _{CC} = Max. Outputs Open, f = f _{MAX}	480	480	mA
I _{SB1}	Full Standby Supply Current	CS ≥ V _{CC} - 0.2V; f = 0 V _{IN} > V _{CC} - 0.2V or < 0.2V	320	120	mA

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TRUTH TABLE

Mode	CS	OE	WE	Output	Power
Standby	H	X	X	High-Z	Standby
Read	L	L	H	DATAOUT	Active
Write	L	X	L	DATAIN	Active
Read	L	H	H	High-Z	Active

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ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Rating	Value	Unit
V _{TERM}	Terminal Voltage with Respect to GND	-0.5 to +7.0	V
TA	Operating Temperature	0 to +70	°C
T _{BIAS}	Temperature Under Bias	-10 to +85	°C
T _{STG}	Storage Temperature	-55 to +125	°C
I _{OUT}	DC Output Current	50	mA

NOTE:

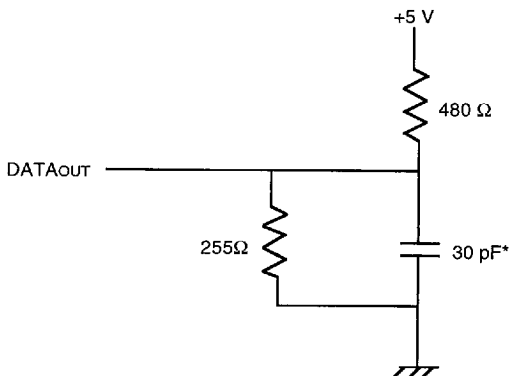
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

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AC TEST CONDITIONS

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	See Figures 1-4

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*Includes scope and jig.

Figure 1. Output Load

2703 drw 03

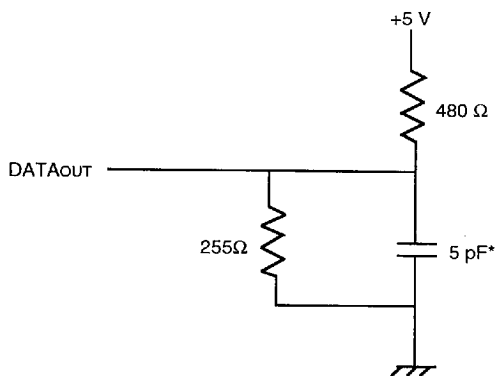


Figure 2. Output Load
(for tOLZ, tOHZ, tCHZ, tCLZ, tWHZ, tOW)

2703 drw 04

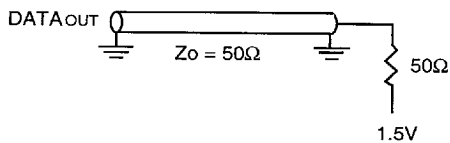


Figure 3. Alternate Output Load

2703 drw 05

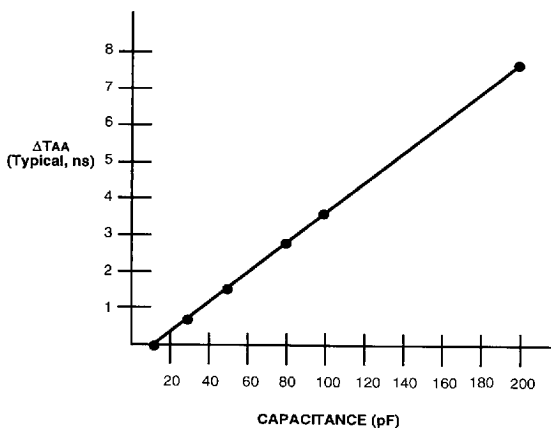


Figure 4. Alternate Lumped Capacitive Load,
Typical Derating

2703 drw 06

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AC ELECTRICAL CHARACTERISTICS

(VCC = 5V ±10%, TA = 0°C to +70°C)

VCC = 5V ±10%, TA = 0 °C to +70 °C

Symbol	Parameter	7MP4045SAxxZ, 7MP4045SAxxM				Unit
		-10		-12		
		Min.	Max.	Min.	Max.	
Read Cycle						
tRC	Read Cycle Time	10	—	12	—	ns
tAA	Address Access Time	—	10	—	12	ns
tACS	Chip Select Access Time	—	10	—	12	ns
tCLZ ⁽¹⁾	Chip Select to Output in Low Z	2	—	2	—	ns
tOE	Output Enable to Output Valid	—	5	—	7	ns
tOLZ ⁽¹⁾	Output Enable to Output in Low Z	0	—	0	—	ns
tCHZ ⁽¹⁾	Chip Deselect to Output in High Z	—	6	—	7	ns
tOHZ ⁽¹⁾	Output Disable to Output in High Z	—	6	—	7	ns
tOH	Output Hold from Address Change	3	—	3	—	ns
Write Cycle						
tWC	Write Cycle Time	10	—	12	—	ns
tCW	Chip Select to End of Write	8	—	10	—	ns
tAW	Address Valid to End of Write	8	—	10	—	ns
tAS	Address Set-up Time	0	—	0	—	ns
tWP	Write Pulse Width	8	—	10	—	ns
tWR	Write Recovery Time	1	—	1	—	ns
tWHZ ⁽¹⁾	Write Enable to Output in High Z	—	5	—	6	ns
tDW	Data to Write Time Overlap	6	—	7	—	ns
tDH	Data Hold from Write Time	1	—	1	—	ns
tOW ⁽¹⁾	Output Active from End of Write	1	—	1	—	ns

NOTE:

1. This parameter is guaranteed by design but not tested.

2703 tbl 10

AC ELECTRICAL CHARACTERISTICS

(VCC = 5V ±10%, TA = 0°C to +70°C)

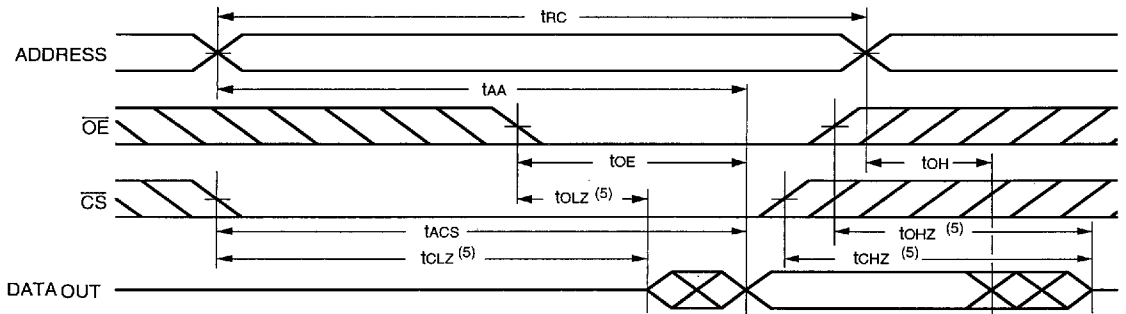
Symbol	Parameter	7MP4045SxxZ, 7MP4045SxxM						Unit
		-15		-20		-25		
		Min.	Max.	Min.	Max.	Min.	Max.	
Read Cycle								
tRC	Read Cycle Time	15	—	20	—	25	—	ns
tAA	Address Access Time	—	15	—	20	—	25	ns
tACS	Chip Select Access Time	—	15	—	20	—	25	ns
tCLZ ⁽¹⁾	Chip Select to Output in Low-Z	3	—	5	—	5	—	ns
tOE	Output Enable to Output Valid	—	8	—	10	—	12	ns
tOLZ ⁽¹⁾	Output Enable to Output in Low-Z	0	—	0	—	0	—	ns
tCHZ ⁽¹⁾	Chip Deselect to Output in High-Z	—	8	—	10	—	12	ns
tOHZ ⁽¹⁾	Output Disable to Output in High-Z	—	8	—	10	—	10	ns
tOH	Output Hold from Address Change	3	—	3	—	3	—	ns
tPU ⁽¹⁾	Chip Select to Power-Up Time	0	—	0	—	0	—	ns
tPD ⁽¹⁾	Chip Deselect to Power-Down Time	—	15	—	20	—	25	ns
Write Cycle								
tWC	Write Cycle Time	15	—	20	—	25	—	ns
tCW	Chip Select to End-of-Write	12	—	15	—	20	—	ns
tAW	Address Valid to End-of-Write	12	—	15	—	20	—	ns
tAS	Address Set-up Time	0	—	0	—	0	—	ns
tWP	Write Pulse Width	12	—	15	—	20	—	ns
tWR	Write Recovery Time	0	—	0	—	0	—	ns
tWHZ ⁽¹⁾	Write Enable to Output in High-Z	—	8	—	13	—	15	ns
tdw	Data to Write Time Overlap	10	—	12	—	15	—	ns
tdH	Data Hold from Write Time	0	—	0	—	0	—	ns
tOW ⁽¹⁾	Output Active from End-of-Write	0	—	0	—	0	—	ns

NOTE:

1. This parameter is guaranteed by design but not tested.

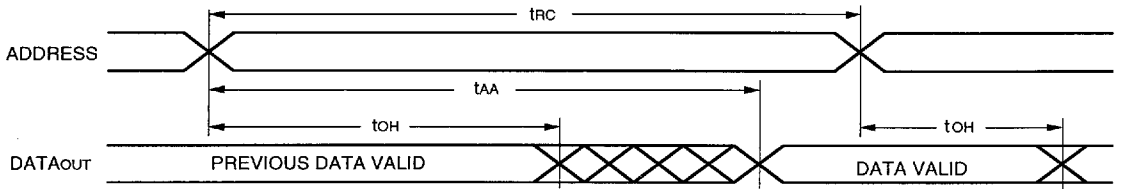
2703 lbl 11

TIMING WAVEFORM OF READ CYCLE NO. 1⁽¹⁾



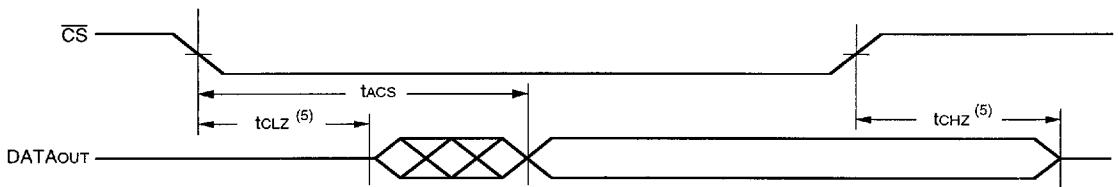
2703 drw 07

TIMING WAVEFORM OF READ CYCLE NO. 2^(1,2,4)



2703 drw 08

TIMING WAVEFORM OF READ CYCLE NO. 3^(1,3,4)

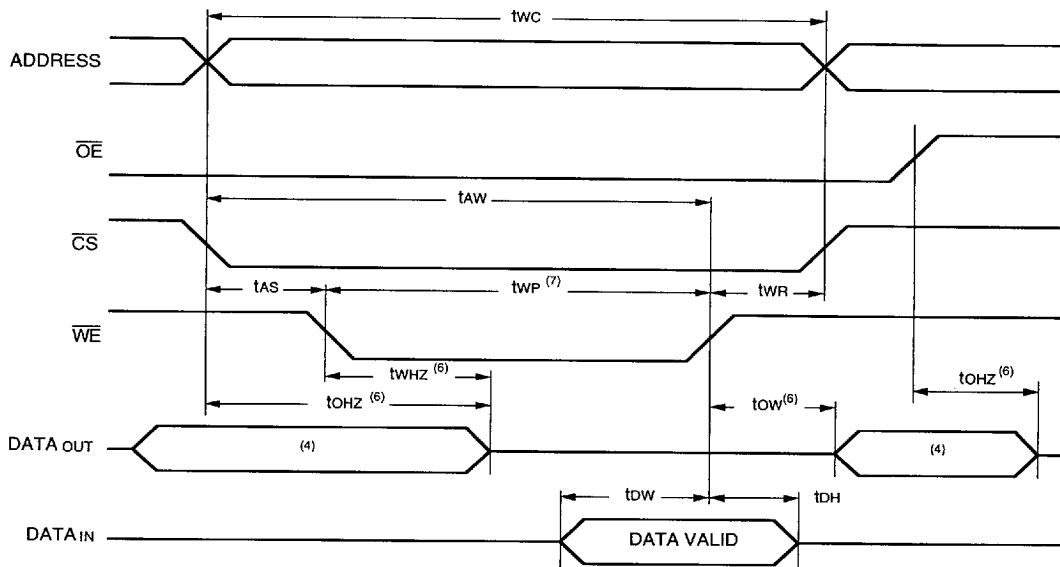


2703 drw 06

NOTES:

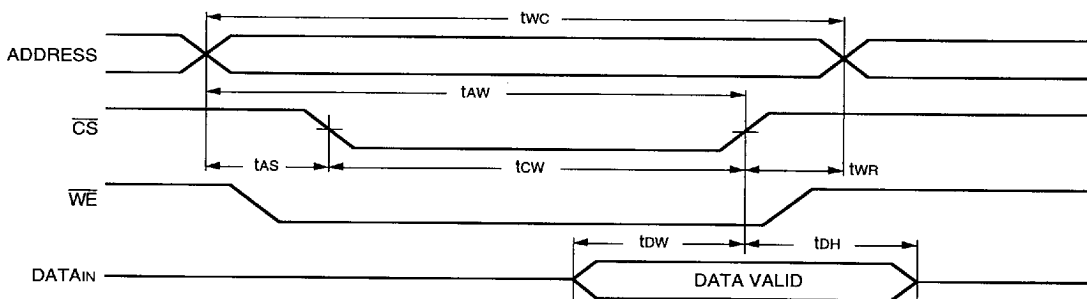
1. $\overline{WE}$ is HIGH for Read Cycle.
2. Device is continuously selected. $\overline{CS} = V_{IL}$.
3. Address valid prior to or coincident with $\overline{CS}$ transition LOW.
4. $\overline{OE} = V_{IL}$.
5. Transition is measured $\pm 200mV$ from steady state. This parameter is guaranteed by design, but not tested.

TIMING WAVEFORM OF WRITE CYCLE NO. 1 ($\overline{WE}$ CONTROLLED) (1, 2, 3, 7)



2703 drw 10

TIMING WAVEFORM OF WRITE CYCLE NO. 2 ($\overline{CS}$ CONTROLLED) (1, 2, 3, 5)



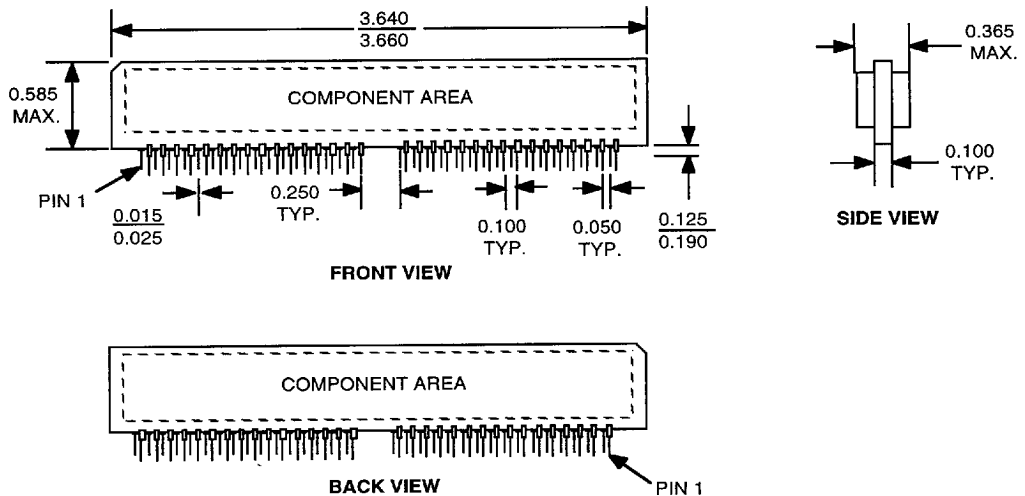
2703 drw 11

NOTES:

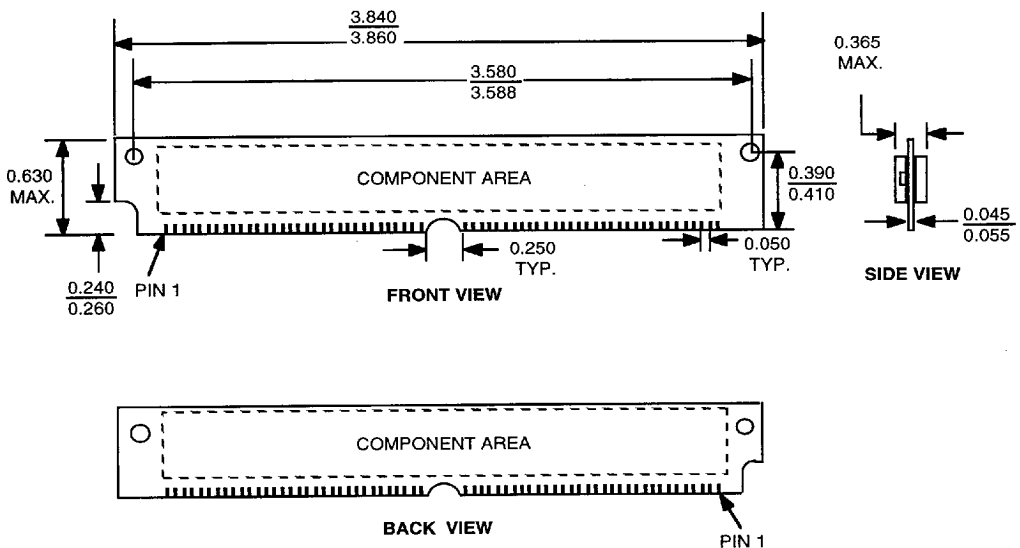
1. $\overline{WE}$ or $\overline{CS}$ must be HIGH during all address transitions.
2. A write occurs during the overlap (t_{WP}) of a LOW $\overline{CS}$ and a LOW $\overline{WE}$.
3. t_{WR} is measured from the earlier of $\overline{CS}$ or $\overline{WE}$ going HIGH to the end of write cycle.
4. During this period, I/O pins are in the output state, and input signals must not be applied.
5. If the $\overline{CS}$ LOW transition occurs simultaneously with or after the $\overline{WE}$ LOW transition, the outputs remain in a high-impedance state.
6. Transition is measured $\pm 200\text{mV}$ from steady state with a 5pF load (including scope and jig). This parameter is guaranteed by design, but not tested.
7. If $\overline{OE}$ is LOW during a $\overline{WE}$ controlled write cycle, the write pulse width must be the larger of t_{WP} or ($t_{WHZ} + t_{OW}$) to allow the I/O drivers to turn off and data to be placed on the bus for the required t_{OW} . If $\overline{OE}$ is HIGH during a $\overline{WE}$ controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified t_{WP} .

PACKAGE DIMENSIONS

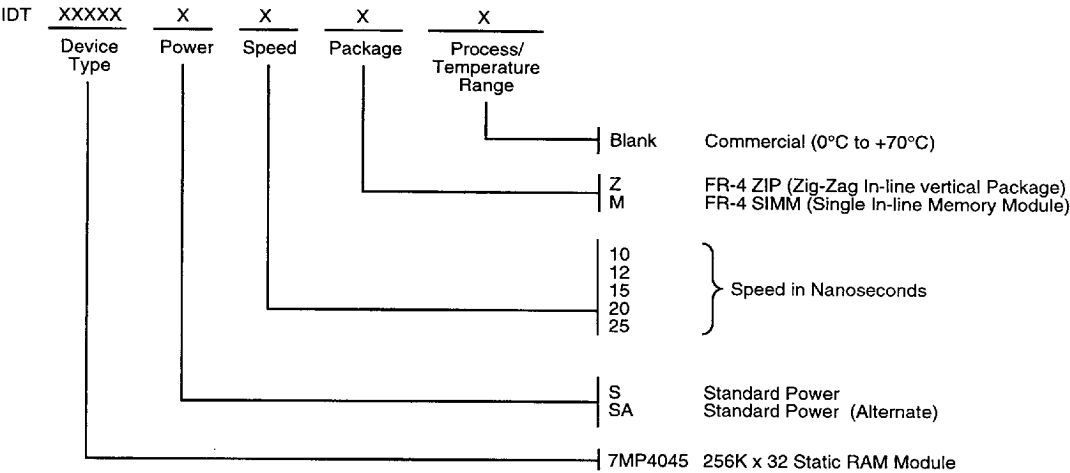
ZIP VERSION



SIMM VERSION



ORDERING INFORMATION



2703 drw 14